

A03400A 30V N-Channel MOSFET

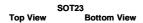
General Description

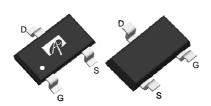
The AO3400A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\rm DS(ON)}$. This device is suitable for use as a load switch or in PWM applications.

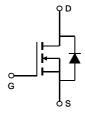
Product Summary

 V_{DS} 30V I_D (at V_{GS} =10V) 5.7A $R_{DS(ON)}$ (at V_{GS} =10V) < 26.5m Ω $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) < 32m Ω $R_{DS(ON)}$ (at $V_{GS} = 2.5V$) < 48m Ω









Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Autoriate maximum ratings 1 _A =20 0 amost state most noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V _{GS}	±12	V			
Continuous Drain	T _A =25℃		5.7				
Current	T _A =70℃	'D	4.7	A			
Pulsed Drain Current ^C		I _{DM}	30				
	T _A =25℃	В	1.4	\\/			
Power Dissipation ^B	T _A =70℃	P _D	0.9	W			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	70	90	€\M			
Maximum Junction-to-Ambient AD	Steady-State R _{0JA}		100	125	€\M			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	C/M			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

STATIC PARAMETERS BV _{DSS} Drain-Source Breakdown Voltage I _D =250μA, V _{GS} =0V 30	Units
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V
T _J =55°C 5 5 5 5 5 5 5 5 5	μА
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	μΑ
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	nA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V
$R_{DS(ON)} \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	А
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mΩ
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	11152
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mΩ
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mΩ
$\begin{array}{ c c c c c }\hline I_S & Maximum Body-Diode Continuous Current & 2 \\ \hline \textbf{DYNAMIC PARAMETERS} \\ \hline C_{iss} & Input Capacitance & 630 \\ \hline C_{oss} & Output Capacitance & V_{GS}=0V, V_{DS}=15V, f=1MHz & 75 \\ \hline C_{rss} & Reverse Transfer Capacitance & 50 \\ \hline R_g & Gate resistance & V_{GS}=0V, V_{DS}=0V, f=1MHz & 1.5 & 3 & 4.5 \\ \hline \textbf{SWITCHING PARAMETERS} \\ \hline Q_g & Total Gate Charge & 6 & 7 \\ \hline Q_{gs} & Gate Source Charge & V_{GS}=4.5V, V_{DS}=15V, I_D=5.7A & 1.3 \\ \hline Q_{gd} & Gate Drain Charge & 1.8 \\ \hline \end{array}$	S
DYNAMIC PARAMETERS C _{iss} Input Capacitance 630 C _{oss} Output Capacitance 75 C _{rss} Reverse Transfer Capacitance 50 R _g Gate resistance V _{GS} =0V, V _{DS} =0V, f=1MHz 1.5 3 4.5 SWITCHING PARAMETERS Q _g Total Gate Charge 6 7 Q _{gs} Gate Source Charge V _{GS} =4.5V, V _{DS} =15V, I _D =5.7A 1.3 Q _{gd} Gate Drain Charge 1.8	V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Α
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	pF
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	pF
SWITCHING PARAMETERS Qg Total Gate Charge 6 7 Qgs Gate Source Charge V _{GS} =4.5V, V _{DS} =15V, I _D =5.7A 1.3 Qgd Gate Drain Charge 1.8	pF
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Ω
Q_{gs} Gate Source Charge V_{GS} =4.5V, V_{DS} =15V, I_{D} =5.7A 1.3 Q_{gd} Gate Drain Charge 1.8	
Q _{gd} Gate Drain Charge 1.8	nC
T O. D.L. T	nC
T O. D.I. T'	nC
t _{D(on)} Turn-On DelayTime 3	ns
t_r Turn-On Rise Time V_{GS} =10V, V_{DS} =15V, R_L =2.6 Ω , 2.5	ns
$t_{D(off)}$ Turn-Off DelayTime R_{GEN} =3 Ω 25	ns
t _f Turn-Off Fall Time 4	ns
t _{rr} Body Diode Reverse Recovery Time I _F =5.7A, dI/dt=100A/μs 8.5	ns
Q _{rr} Body Diode Reverse Recovery Charge I _F =5.7A, dl/dt=100A/μs 2.6	nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

Rev 3: Dec 2011 Page 2 of 5 www.aosmd.com

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.1}=25° C.

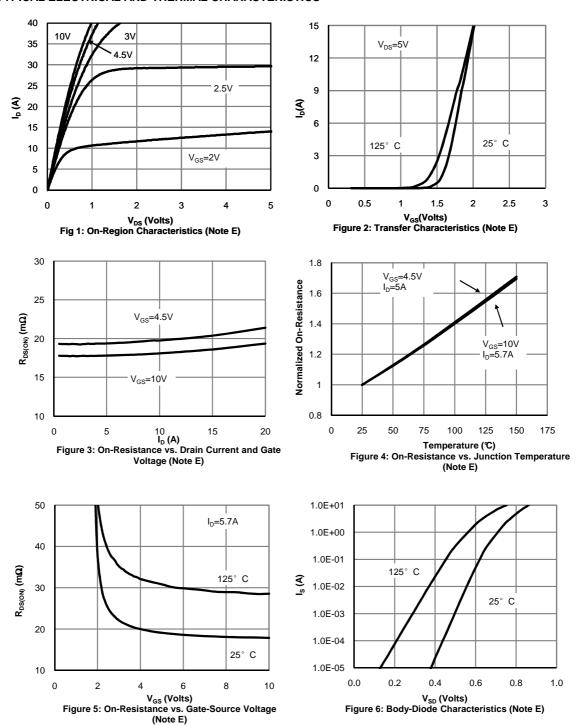
D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}$ =150 $^{\circ}$ C. The SOA curve provides a single pulse rating.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

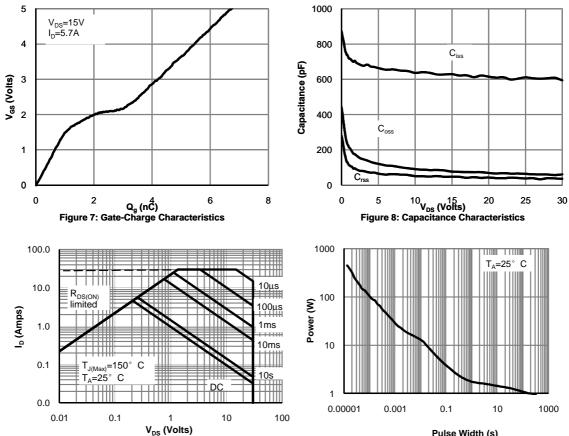


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toAmbient (Note F)

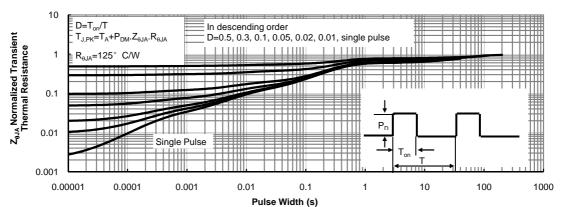
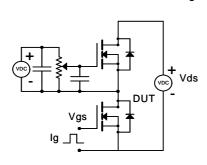
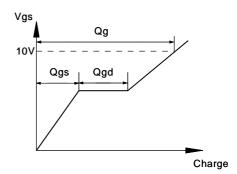


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

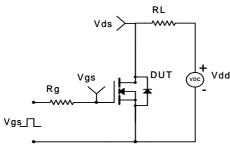


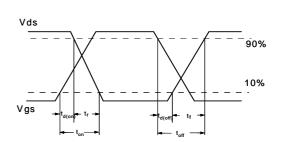
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

